Ĺ	Hits	Search Text	DB	Time stamp
Number				
1	75478	438/\$.ccls.	USPAT;	2004/03/11
			US-PGPUB	18:15
2	536100	semiconductor or ic or "integrated circuit" or	USPAT;	2004/03/11
		microelectronic	US-PGPUB	18:15
3	1	("6555401").PN.	USPAT	2004/03/11
			US-PGPUB	18:15
4	135502	polish\$3	USPAT:	2004/03/11
			US-PGPUB	18:15
5	134806	rins\$3	USPAT;	2004/03/11
			US-PGPUB	18:15
6	2045	polish\$3 with rins\$3	USPAT:	2004/03/11
			US-PGPUB	18:15
7	536100	semiconductor or ic or "integrated circuit" or	USPAT;	2004/03/11
		microelectronic	US-PGPUB	18:15
8	1083	(polish\$3 with rins\$3) and (semiconductor or ic or	USPAT;	2004/03/11
		"integrated circuit" or microelectronic)	US-PGPUB	18:15
9	636181	gradual or gradually or transition	USPAT;	2004/03/11
			US-PGPUB	18:15
10	38	(polish\$3 with rins\$3) with (gradual or gradually or	USPAT	2004/03/11
		transition)	US-PGPUB	18:15
11	37	(semiconductor or ic or "integrated circuit" or	USPAT;	2004/03/11
		microelectronic) and ((polish\$ 3 with rins\$ 3) with	US-PGPUB	18:16
		(gradual or gradually or transition))		

AST - (defaultminest)	
Domest and the state of the sta	<u>X</u>
∫ ^{III} Drafts	157 Det Breen Quant
Pending	DBs USPAT P Purais
Active	Defeut operator. 17 Highlight all hit terms initially
L1: (13932) (polish\$ or CMP) with (rins\$ or clean\$)	ana da 📩
¹² 2: (138+58+) metal or metals	
⁵⁵ _ 3: (1198) 1 with 2	
L+: (75+78) +38/\$7.ccls.	
5: (213) 3 and 4	
6: (2978221) @ad<19991231	
≤ L7: (76) 5 and 6	
[] ¹ 28: (1) ("5876271").PN.	
↓ 19: (86221) H2O2 or hydrogenperoxide or "hydrogen peroxide" or "hydrogen-peroxide" or "H.sub.2O	
SS	
Failed	
Javed	
Favorites	
₩ Tagged (0)	
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Trash	A BRS F. A BERT. Strope Pt Test B HTM
U 1 Document]ssue Da Pag Title Current X Retrieval	Inventor 5 C 7 2 3
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